

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 09/635,735 | Applicant(s)/Patent Under Reexamination ALLIBHOY ET AL | |
| | Examiner David Q Le | Art Unit 3621 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | A | US-5892900 | 04-1999 | Ginter et al | 395/186 |
| | B | US-6282713 | 08-2001 | Kitsukawa et al | 725/36 |
| | C | US-5740549 | 04-1998 | Reilly et al | 705/14 |
| | D | US-6131086 | 10-2000 | Walker et al | 705/26 |
| | E | US-6182052 | 01-2001 | Fulton et al | 705/26 |
| | F | US-6286045 | 09-2001 | Griffiths et al | 709/224 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.